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December 18, 2002

**BY ELECTRONIC FILING**

Ms. Marlene Dortch  
Federal Communications Commission  
445 12<sup>th</sup> Street, S.W.  
Washington, D.C. 20554

**Re: Oral Ex Parte Presentation**  
**ET Docket No. 98-153**

Dear Ms. Dortch:

This is to report that on December 17, 2002, representatives of QUALCOMM, Cingular Wireless, and Verizon Wireless (the "Wireless Companies") met with the staff of the Office of Engineering & Technology ("OET") to discuss the Comments filed on November 22, 2002 by QUALCOMM on the ambient study released by the staff of the Office of Engineering and Technology. Attending the meeting on behalf of the Wireless Companies were Dr. Samir Soliman, Klein Gilhousen, Dr. Chuck Wheatley, Jonas Neihardt, and myself on behalf of QUALCOMM; Jim Bugel on behalf of Cingular Wireless; and, Don Brittingham on behalf of Verizon Wireless. Attending the meeting on behalf of OET were Ed Thomas, Julius Knapp, John Reed, Steve Jones, Karen Rackley, and Alan Scrimme.

During the meeting, Dr. Soliman explained QUALCOMM's Comments on OET's ambient noise study. Dr. Soliman also discussed the results of QUALCOMM's own ambient noise testing. The OET Staff responded to the issues raised by QUALCOMM concerning OET's testing and provided additional information about OET's testing. During the meeting, it was agreed that Dr. Soliman and QUALCOMM's technical team would exchange information with the OET staff concerning their respective tests and would work together to attempt to understand why the results of the two sets of tests differ.

Sincerely yours,

/s/ Dean R. Brenner

Dean R. Brenner  
Attorney for QUALCOMM Incorporated

Cc: Ed Thomas  
Julius Knapp  
John Reed  
Steve Jones  
Karen Rackley  
Alan Scrim